

Clarification of the relationship between SiC/SiO₂ interface structures and electronic properties

Number of project members

5

Cygnus: Project code

[No]

Cygnus: Requested [awarded] number of nodes

[0]

Cygnus: Requested [awarded] node-hour product

[0]

Cygnus: Requested [awarded] disk capacity (TB)

[0]

OFP: Project code

[xg19i063]

OFP: Requested [awarded] number of nodes

[1024]

OFP: Requested [awarded] node-hour product

300000 [213333]

OFP: Requested [awarded] disk capacity (TB)

[20]

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Track Classification : Material Science(物質科学分野)